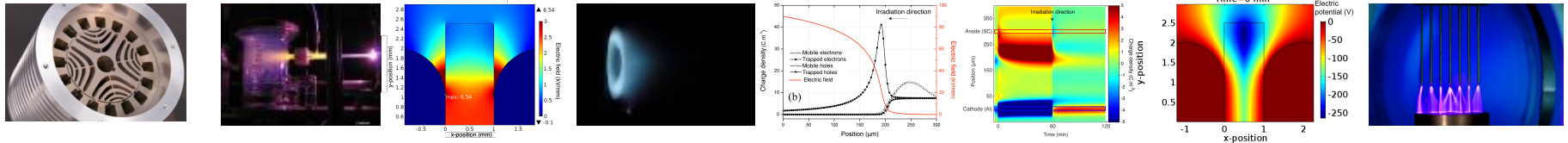


Partial discharge risk under space charges generation and transport effects

M. E. BANDA*, D. MALEC, J-P. CAMBRONNE
banda@laplace.univ-tlse.fr

LAPLACE, Toulouse University, CNRS, INPT, UPS, France.

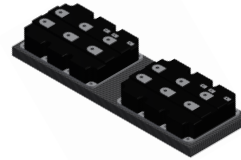


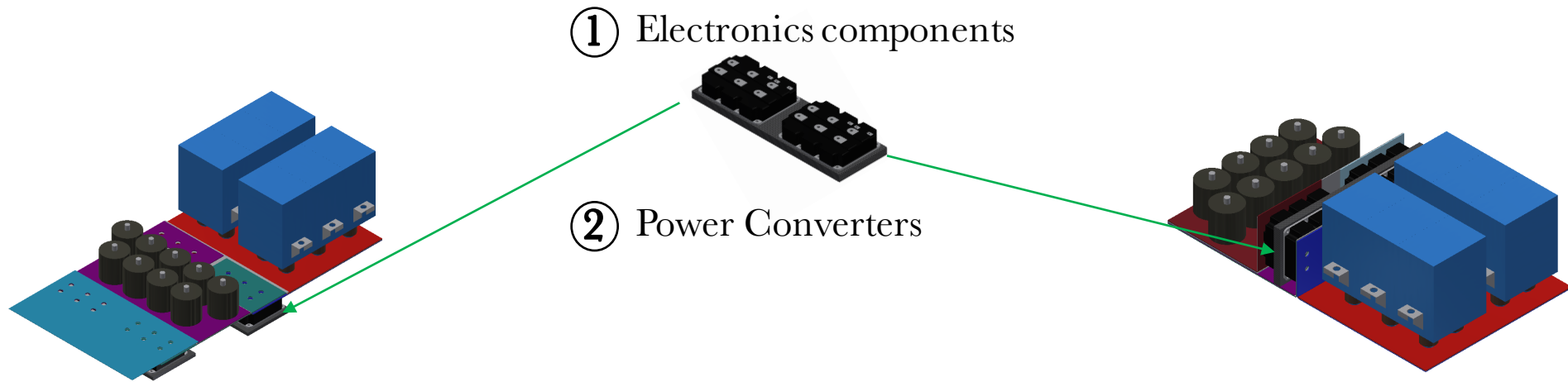
STUDY CONTEXT AND PROBLEMATIC

COMSOL[®] IMPLEMENTATION & SIMULATION MODEL

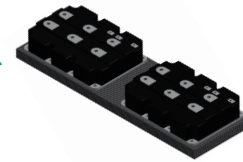
MAIN SIMULATION RESULTS

① Electronics components

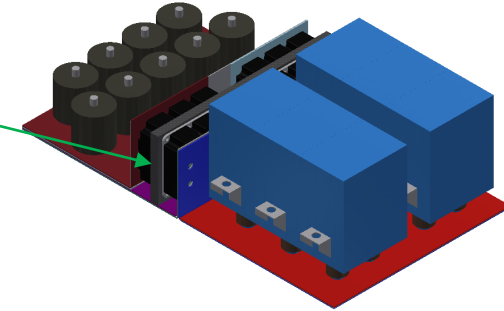




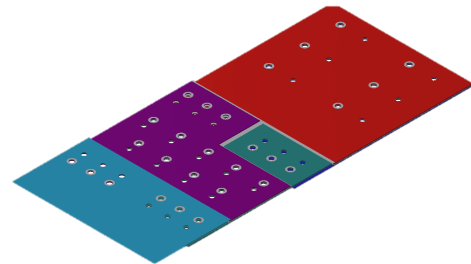
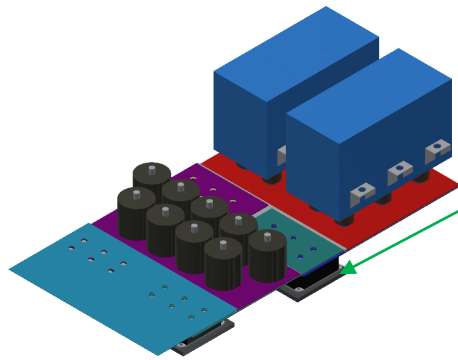
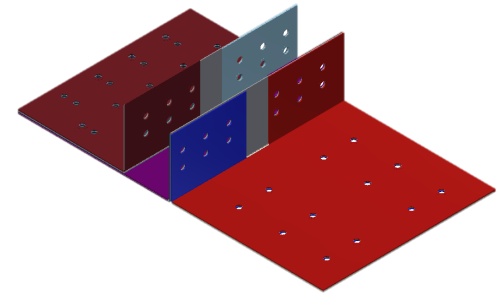
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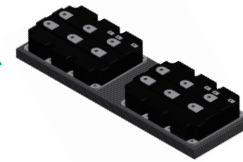
② Power Converters



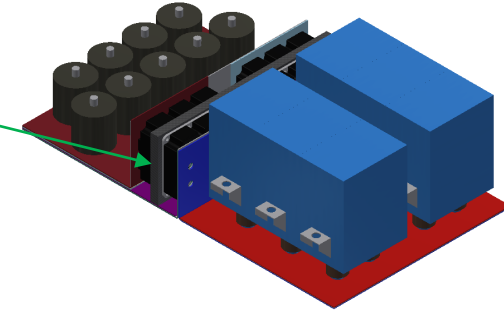
③ Busbars powered by a HVDC 2.5kV voltage bus



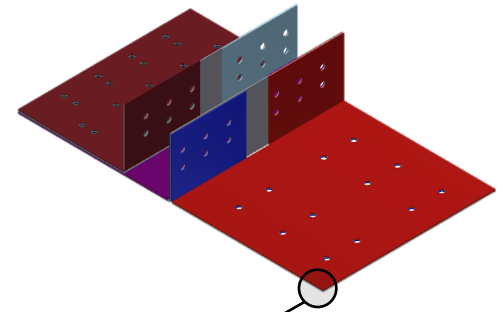
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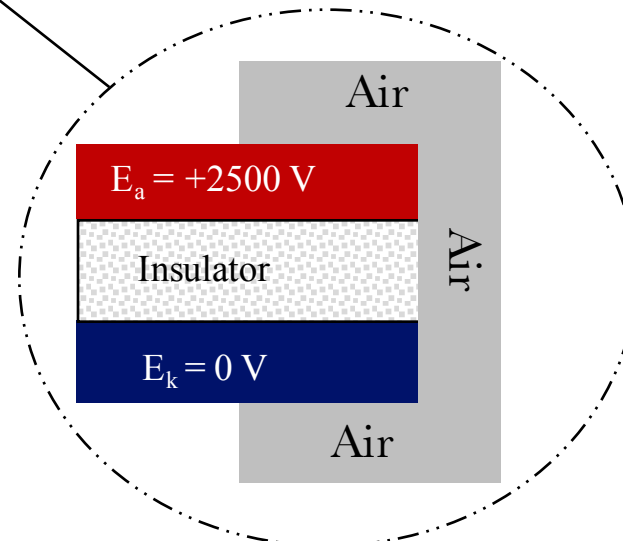
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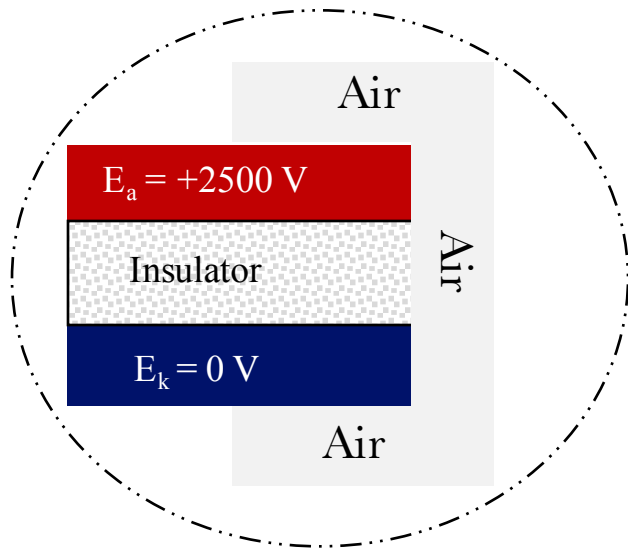
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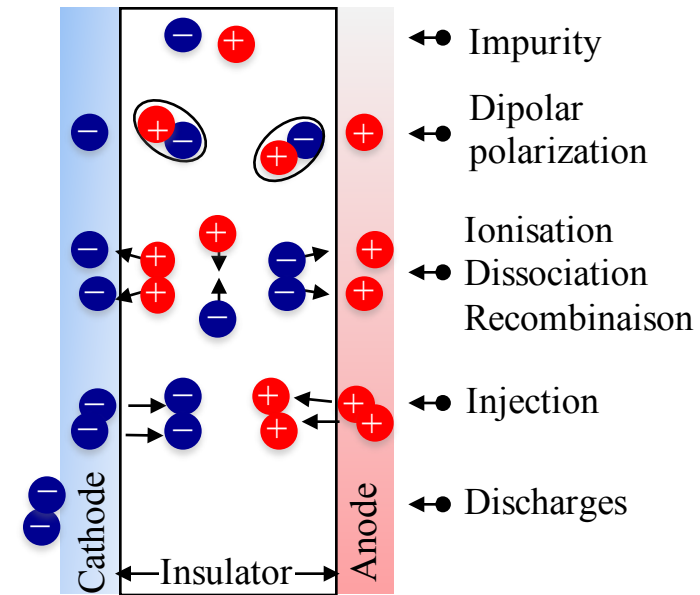
④ Triple point =
 Conductor_(busbar)
 +
 dielectrics_(insulator)
 +
 Air contact region



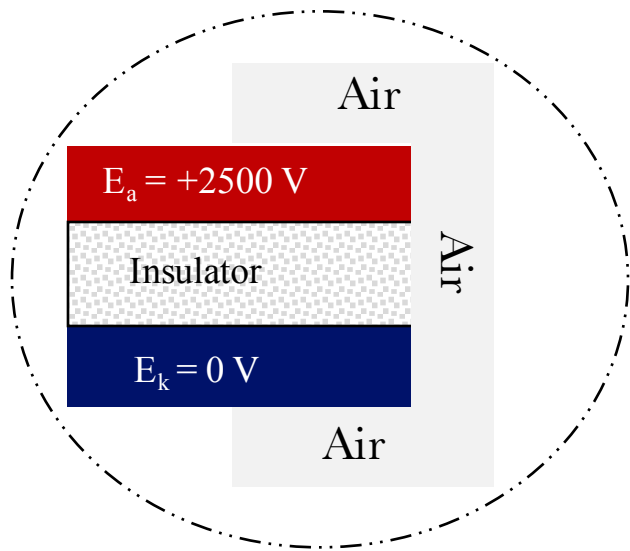
Study context and problem - Charge generation in dielectrics materials



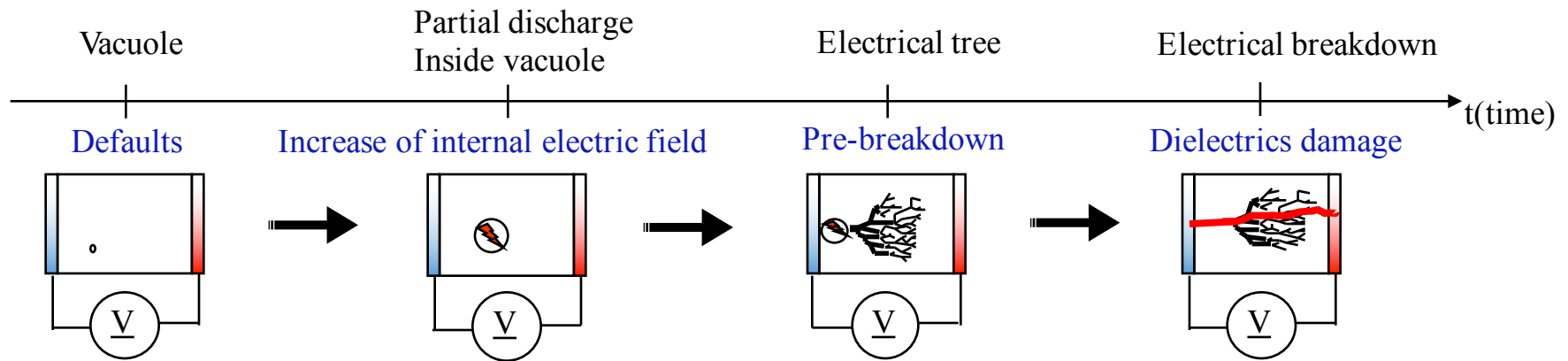
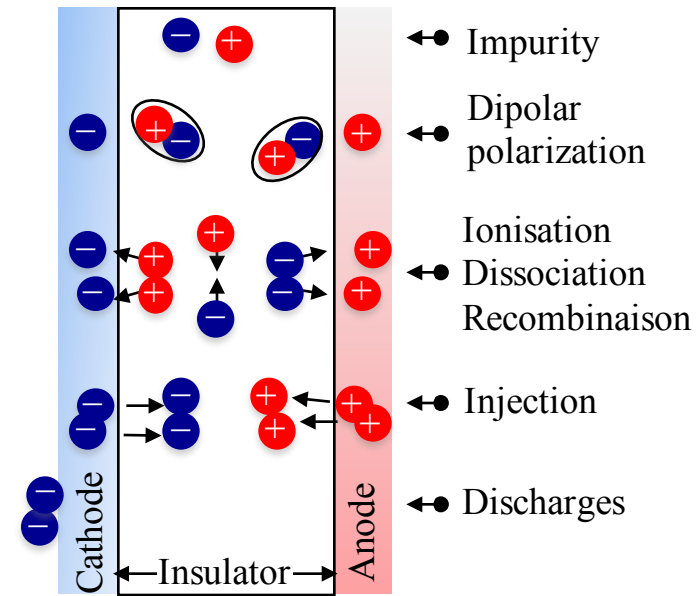
Main charge generation mechanisms



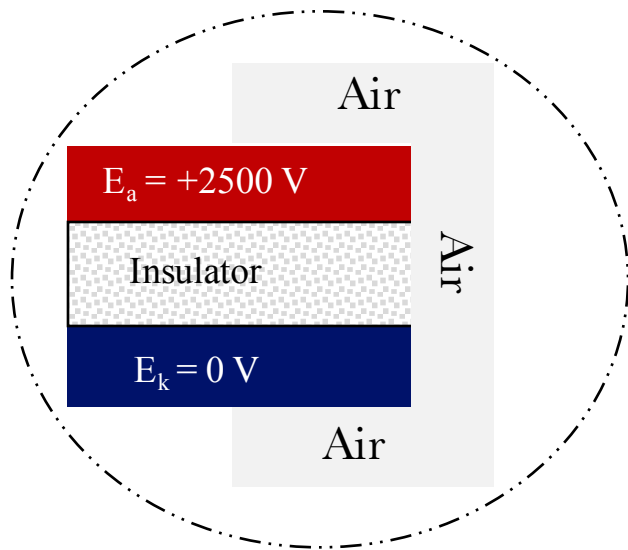
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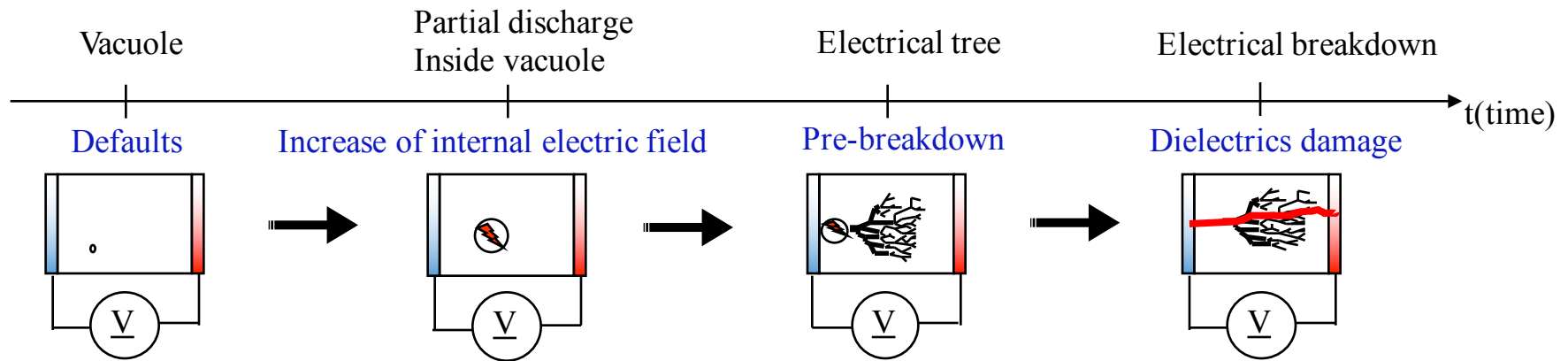
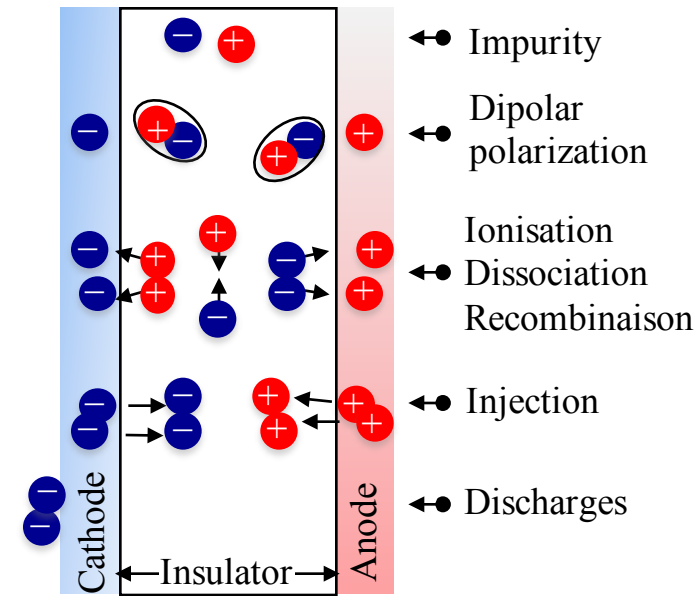
Main charge generation mechanisms



Study context and problem - Charge generation in dielectrics materials



Main charge generation mechanisms



A better characterization of charge mechanisms in dielectrics material to prevent partial discharge risk in air surrounding HVDC power systems.

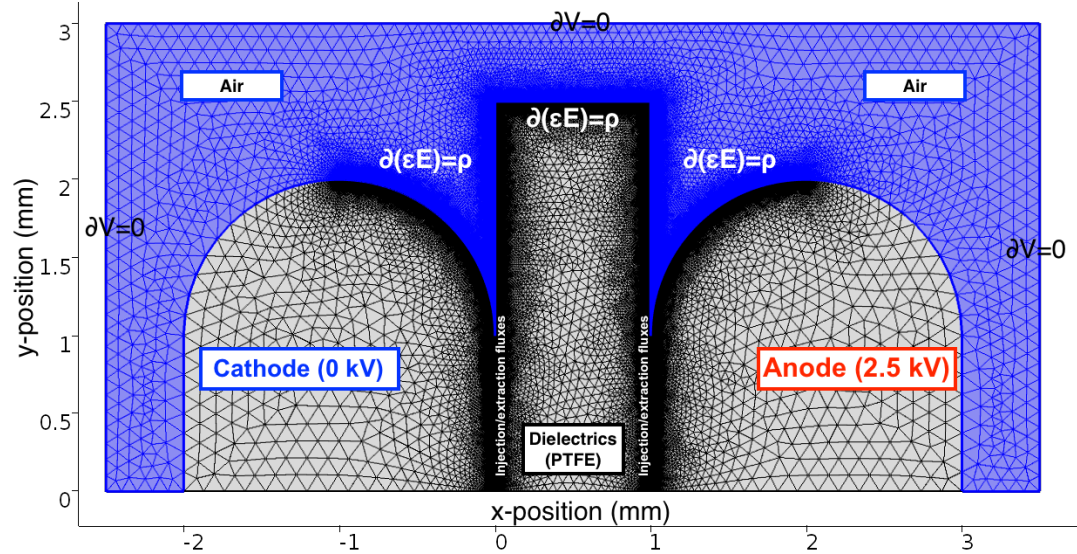
STUDY CONTEXT AND PROBLEMATIC

COMSOL® IMPLEMENTATION & SIMULATION MODEL

MAIN SIMULATION RESULTS

Geometry and meshing

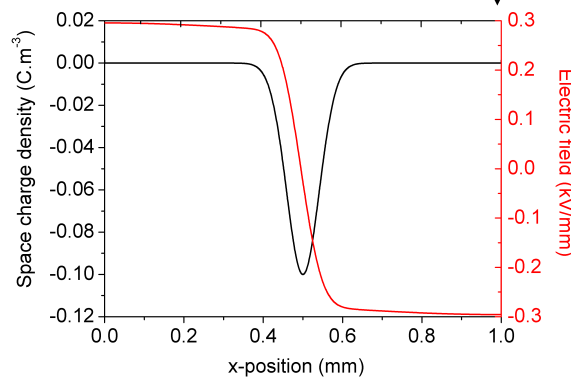
- 2D-simulation model
- 162 k domain elements
- ~4 M Finite elements
- Interfaces refinement
- 50 Boundary layers



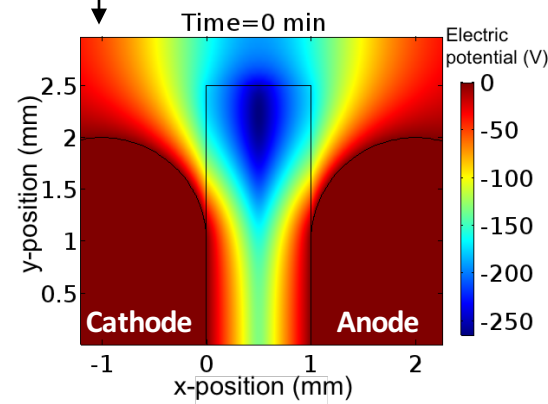
Initial conditions

- $\rho = \text{Variable distribution}$
- $p = 1 \text{ bar}$
- $T^\circ \sim 293,15 \text{ K} (20^\circ \text{C})$

Initial charge and associated Electric field distribution

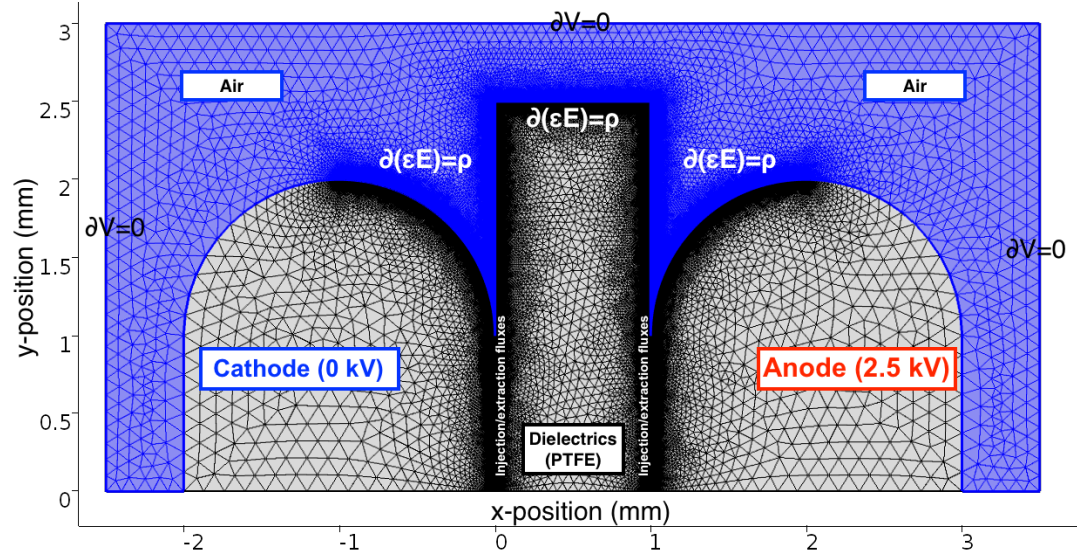


Potential distribution



Geometry and meshing

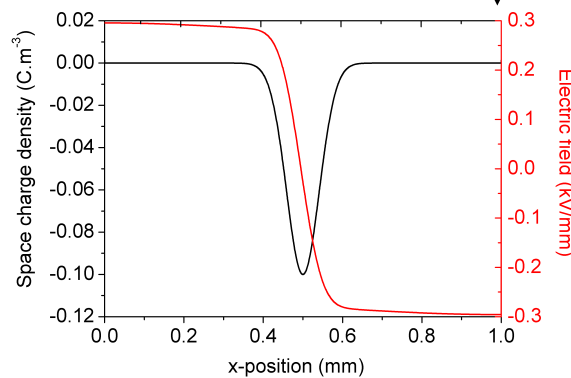
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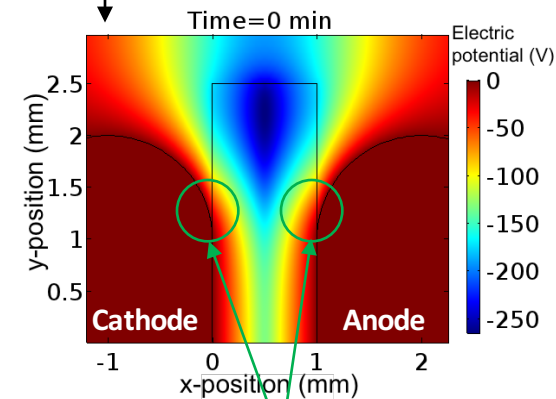
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Initial charge and associated Electric field distribution



Potential distribution



Triple points

Main model equations

- Poisson equation :
$$\frac{\partial E(x, y)}{\partial x \partial y} = \frac{\rho(x, y)}{\epsilon_r \epsilon_0}$$
- Transport equation
$$j(x, t) = n(x, t) \cdot \mu(E, t) \cdot E(x, t)$$
- Continuity equation :
$$\frac{\partial \rho(x, t)}{\partial t} + \frac{\partial j(x, t)}{\partial x} = s(x, t)$$

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- $j(x, t)$ the injection/extraction at interfaces :
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- $s(x, t)$, Source terms (case of mobile electrons)

$$s_{e\mu}(x, t) = \underbrace{-B_e \cdot n_{e\mu} \left(1 - \frac{n_{et}}{N_{0, et}}\right)}_{\text{trapping}} + \underbrace{n_{et} \cdot v \exp\left(-\frac{\phi_{tre}}{k_B T}\right)}_{\text{detrapping}} - \underbrace{S_1 \cdot n_{e\mu} \cdot n_{ht} - S_3 \cdot n_{e\mu} \cdot n_{h\mu}}_{\text{recombination}}$$

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11 variables to compute for model solving - Implementation under **General-PDE modules**

STUDY CONTEXT AND PROBLEMATIC

COMSOL® IMPLEMENTATION & SIMULATION MODEL

MAIN SIMULATION RESULTS

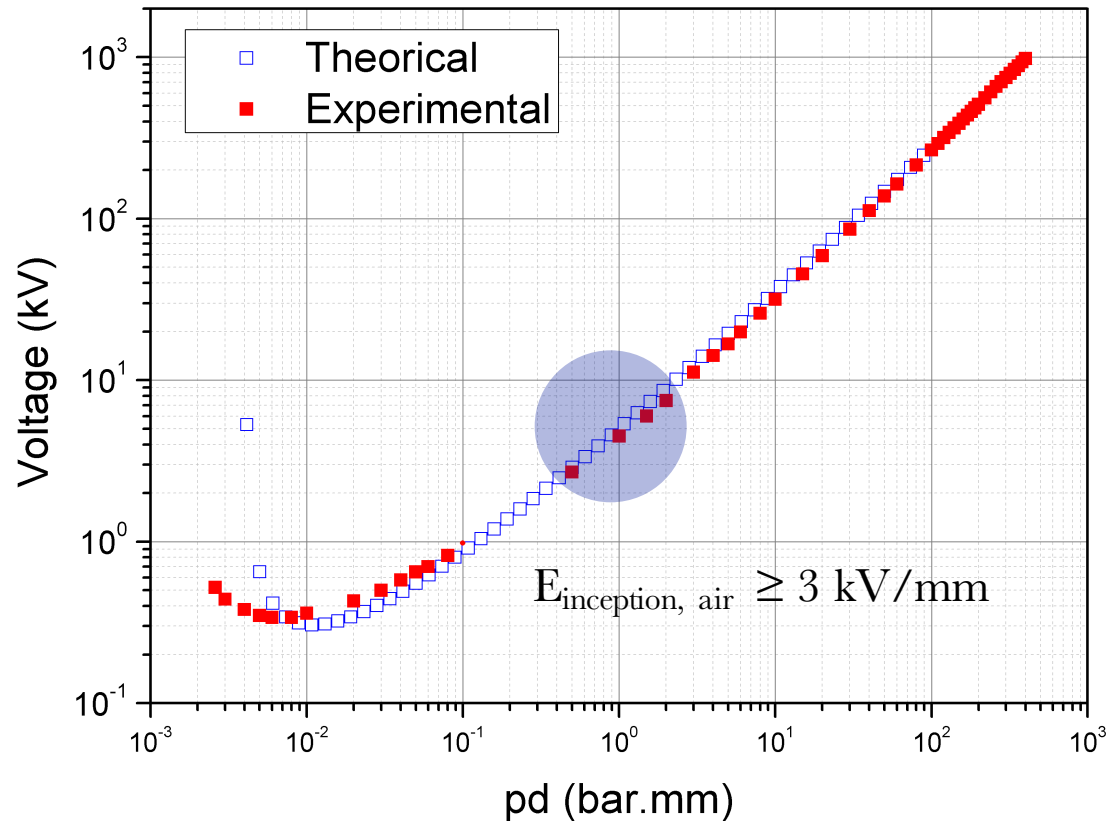
{
 (P, T°) = (1,013 bar, 20°C) ;
 Uniforme electric field /air gap ;
 Plane electrodes ;

$$U_p = \frac{B \cdot (pd)}{\ln(pd) + \frac{A}{\ln\left(1 + \frac{1}{\gamma}\right)}}$$

$$A_{air} \approx 15 \text{ (Torr}^{-1} \cdot \text{cm)}$$

$$B_{air} \approx 365 \text{ (V} \cdot \text{Torr}^{-1} \cdot \text{cm}^{-1})$$

$$\gamma_i = \frac{n_{\text{secondary}}}{n_{\text{ion}}}$$

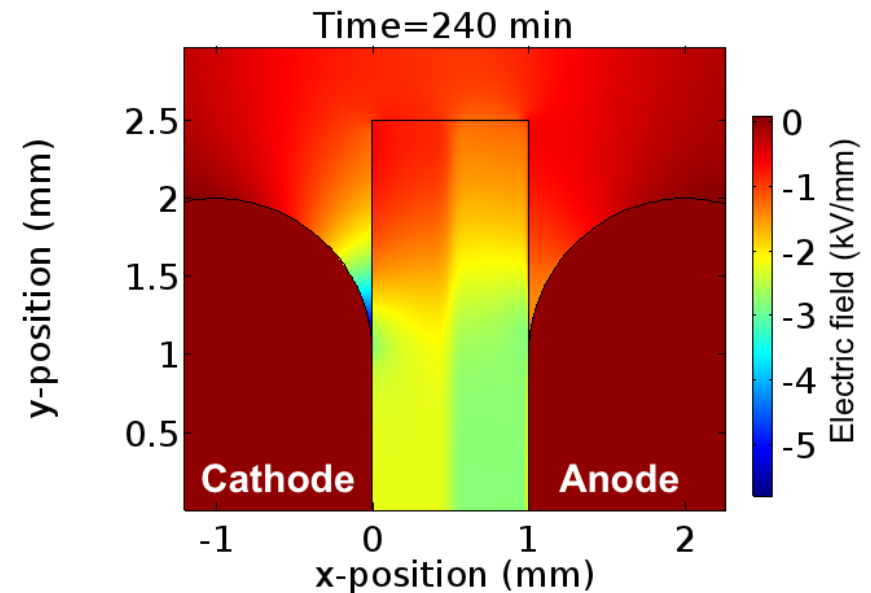
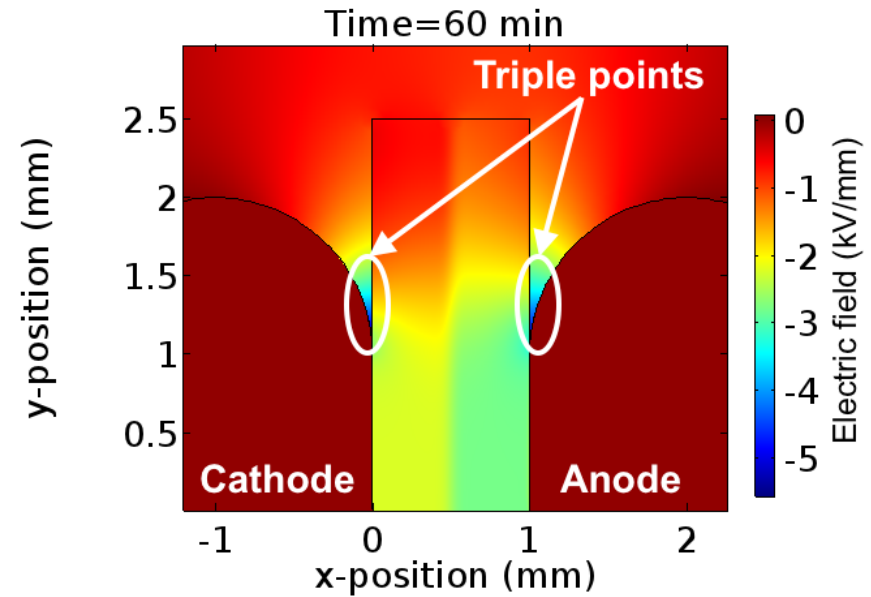


[1] F. Paschen Über die zum Funkenübergang in Luft, Wasserstoffand Kohlensäure bei verschiedenen Drücken erforderliche Potentialdifferenz, Wied. Annalen der Physik und Chemie. Wiede-manns Annalen, Ser. 3, 37(1), 69 (1889)

Electric field at triple points

- $E_{\max}(x, t)$ decreases by 72% at anode triple point and increases by 4% at cathode triple point ;
- Implanted charges disturb the electric field distribution in dielectrics ;
- $|E_{\max}(x, t)|$ in air ≥ 3 kV/mm ;

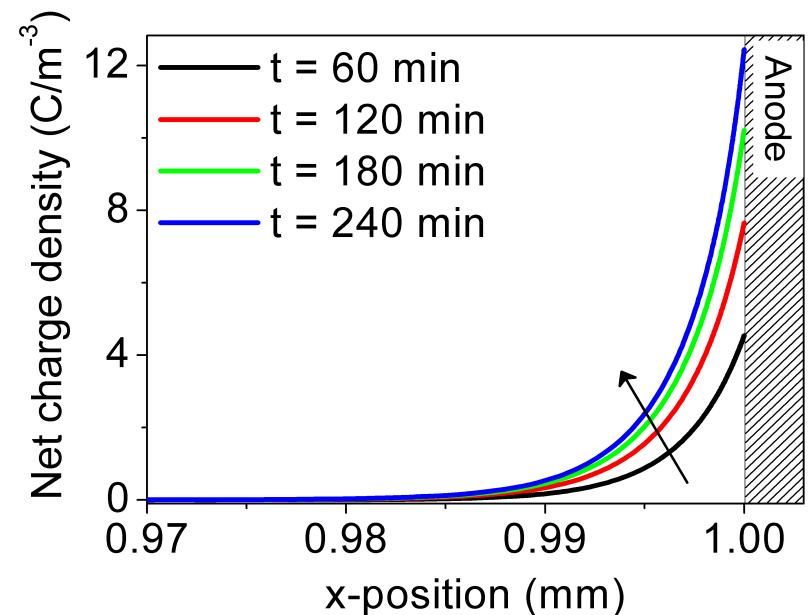
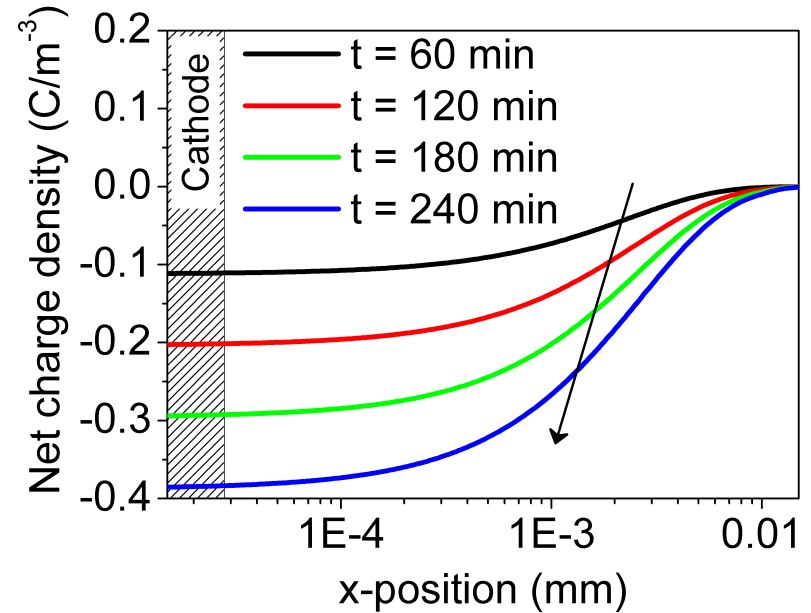
Partial discharge risk at triple points.



Charge injection mechanism at triple points

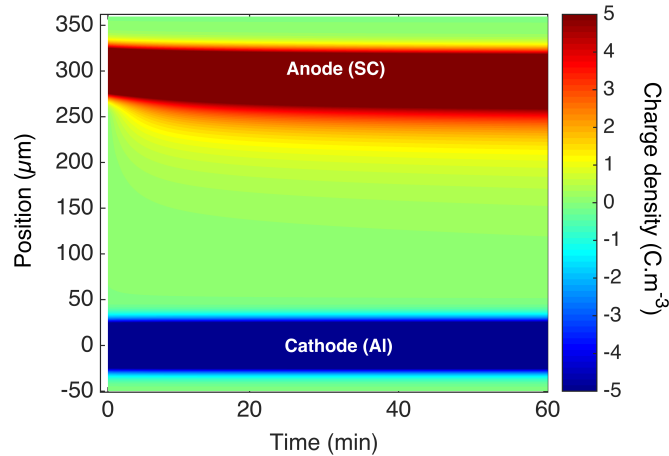
- More holes injection from anode than electrons from cathode ;
- Each charge type increases with time at both interfaces ;
- Low trapping and transport mechanisms in the bulk with time ;

The nature and distribution of injected charges has a significant impact on partial discharge risk at triple points.

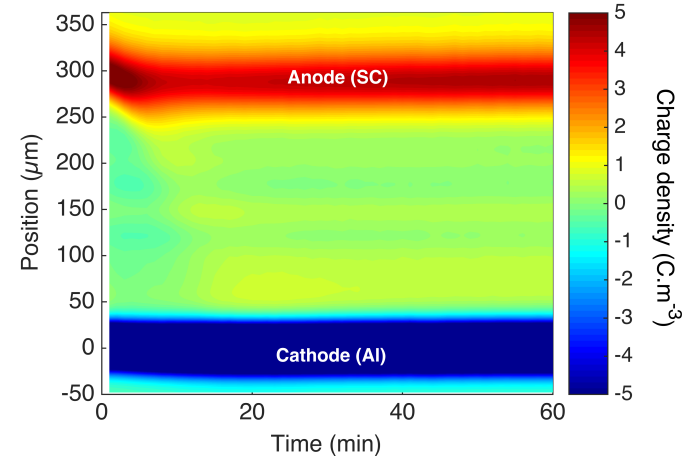


Simulated Model giving well agreement with experimental measurements for **LDPE** material

Simulation



Measurement



Confrontation with **PTFE** experimental measurements

Use of Powerful Comsol[®] solver to compute the model more quickly than Fortran[®] source code

THANK YOU FOR YOUR ATTENTION